

243 Jubug-ri, Yangji-myeon, Cheoin-gu, Yongin-si, Gyeonggi-do 449-822, Korea Tel: +82-31-323-6008 Fax: +82-31-323-6010 <u>http://www.ltalab.com</u>

EMC TEST REPORT

Dates of Tests: June 28 – July 03, 2018 Test Report S/N: LR500121807E Test Site : LTA Co., Ltd.

Model No.

APPLICANT

IDIS CO., LTD.

DR-1304PC

Equipment Name	:	Network Video Recorder
Manufacturer	:	IDIS CO., LTD.
Model name	:	DR-1304PC
Additional Model name	:	NR-1304PC
Test Device Serial No.:	:	Identification
Directive	:	Electromagnetic Compatibility Directive 2014/30/EU
Rule Part(s)	:	EN 55032:2015
		EN 50130-4:2011/A1:2014
		EN 61000-3-2:2014
		EN 61000-3-3:2013
Data of reissue	:	July 06, 2018

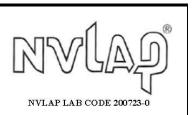
This test report is issued under the authority of:

Young Kyu Shin, Technical Manager

Young Ho, Bang, Test Engineer

The test was supervised by:

This test result only responds to the tested sample. It is not allowed to copy this report even partly without the allowance of the test laboratory. The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.



Revision	Date of issue	Test report No.	Description
0	06.07.2018	LR500121807E	Initial

TABLE OF CONTENTS

4
5
7
7
8
8
14
19
21
24
24
27
29
31
32

1. General information's

1-1 Test Performed

Company name	:	LTA Co., Ltd.
Address	:	243, Jubug-ri, Yangji-Myeon, Yongin-Si, Kyunggi-Do, Korea. 449-822
Web site	:	http://www.ltalab.com
E-mail	:	chahn@ltalab.com
Telephone	:	+82-31-323-6008
Facsimile		+82-31-323-6010
Quality control in the test	ing	laboratory is implemented as per ISO/IEC 17025 which is the "General

requirements for the competents of calibration and testing laboratory".

1-2 Accredited agencies

LTA Co., Ltd. is approved to perform EMC testing by the following agencies:

Agency	Country	Accreditation No.	Validity	Reference
NVLAP	U.S.A	200723-0	2018-09-30	ECT accredited Lab.
RRA	KOREA	KR0049	-	EMC accredited Lab.
FCC	U.S.A	649054	2019-04-13	FCC CAB
	C-4948,	2020-09-10		
VCCI	VCCI JAPAN	T-2416,	2020-09-10	VCCI as sistration
VCCI		R-4483(10 m),	2020-10-15	VCCI registration
		G-847	2018-12-13	
IC	CANADA	5799A-2	2019-03-15	IC filing
KOLAS	KOREA	NO.551	2021-08-20	KOLAS accredited Lab.

2. Information's about test item

2-1 Client/ Manufacturer

Company name	:	IDIS CO., LTD.
Address	:	8-10, TECHNO 3-RO, YUSEONG-GU, DAEJEON, KOREA
Telephone / Facsimile	:	+82-31-723-5205 / +82-31-723-5108
Factory 1		
Company name		IDIS CO., LTD.
Address		8-10, TECHNO 3-RO, YUSEONG-GU, DAEJEON, KOREA
<u>2-2 Equipment Under Te</u>	est ((EUT)
Class	:	A
Equipment Name	:	Network Video Recorder
Model name	:	DR-1304PC
Additional Model name	:	NR-1304PC
		DR-1304PC is basic model, which was tested.
		NR-1304PC is identical to DR-1304PC except for Model Name, marketing purpose.
Serial number	:	Identification
Date of receipt	:	June 12, 2018
EUT condition	:	Pre-production, not damaged
Interface ports	:	DC IN, USB 2.0 #1, USB 2.0 #2, HDMI, VGA, LAN, PoE LAN
Power rating	:	DC 48 V, 1 A
Modulator	:	-
Crystal/Oscillator(s)	:	-
Firmware version	:	XXXX
2-3 Modification		
-NONE		
2-4 Model Specification		
-NONE		
2-5 Test conditions		
Temp. / Humid. / Pressure	:	+(23 - 25) °C / (49 - 50) % R.H. / (100.1) kPa
Tested Model	:	DR-1304PC
Test mode	:	Rec mode
Power supply	:	AC 230 V, 50 Hz

<u>2-5 EUT</u>

Equipment	Model No.	Serial No.	Manufacturer	
Network Video Recorder	DR-1304PC	N/A	IDIS CO., LTD.	
Accessary				
Equipment	Model No.	Serial No.	Manufacturer	
Notebook	P56	N/A	HANSUNG	
Monitor #1	P2416D	N/A	DELL	
Monitor #2	Р2317Н	N/A	DELL	
Camera	N/A	N/A	IDIS CO., LTD	
Keyboard	SK-8115	N/A	DELL	
Mouse	1484	N/A	Micro Soft	

2-7 Cable List

F	From			Length	Shi	ielding
Туре	I/O Port	Туре	I/O Port	(m)	Cable	backshell
	DC IN	Adapter	DC OUT	2.0	NO	Plastic
	USB 2.0	Keyboard	USB	1.0	NO	Plastic
	USB 2.0	Mouse	USB	1.0	NO	Plastic
EUT	LAN	Notebook	LAN	3.0	NO	Plastic
	HDMI	Monitor #1	HDMI	1.5	NO	Plastic
	VGA	Monitor #2	VGA	1.5	NO	Plastic
	PoE LAN	Camera	LAN	3.0	NO	Plastic
Notebook	DC IN	Adapter	DC OUT	2.0	NO	Plastic
Monitor #1	AC IN	AC Power Source	3 Pin AC Line	1.5	NO	Plastic
Monitor #2	AC IN	AC Power Source	3 Pin AC Line	1.5	NO	Plastic

3. Test Report

3.1 Summary of tests

Parameter	Applied Standard	Status		
I. Emission				
Radiated Emission	EN 55032:2015	С		
Conducted Emission	EN 55032:2015	С		
Harmonic Current Emission	EN 61000-3-2:2014	NA Note 3		
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	С		
II. Immunity				
Electrostatic Discharge	EN 61000-4-2:2009	С		
RF Electromagnetic field	EN 61000-4-3:2006/A1:2008/A2:2010	С		
Fast Transients Common mode	EN 61000-4-4:2012	С		
Surges, line to line and line to ground	EN 61000-4-5:2014	С		
RF common mode	EN 61000-4-6:2014/AC:2015	С		
Voltage dips and Interruptions	EN 61000-4-11:2004/A1:2017	С		
Main supply voltage variations	EN 50130-4:2011/A1:2014	С		

<u>Note 1</u>: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

<u>Note 2</u>: The data in this test report are traceable to the national or international standards.

<u>Note 3:</u> We did not test EN61000-3-2 (Harmonic current emissions) for the DR-1304PC because equipment whose rated power is less or equal 75W don't need to be tested.

3.2 EMISSION

3.2.1 Conducted emissions

Definition:

The test assesses the ability of the EUT to limit its internal noise from being present on the AC mains Power In/Output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Measurement Frequency range	:	150 kHz – 30 MHz
Test method	:	EN 55032:2015
Measurement RBW	:	9 kHz
Test mode	:	Rec mode
Result	:	Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)

A sample calculation:

COR. F (correction factor)= LISN Insertion loss + Cable loss + Pulse Limiter Factors

Emission Level= meter reading + COR.F

Limits for conducted disturbance at the mains ports of class A ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	79 dBuV	66 dBuV
(0.5 – 30) MHz	73 dBuV	60 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15MHz to 0.5MHz

Limits for conducted disturbance at the mains ports of class B ITE

Frequency Range	Quasi-peak	Average	
(0.15 – 0.5) MHz	(66 – 56) dBuV	(56 - 46) dBuV	
(0.5 – 5) MHz	56 dBuV	46 dBuV	
(5 – 30) MHz 60 dBuV 50 dBuV			
Note: The limits will decrease with the frequency logarithmically within 0.15 MHz to 0.5 MHz			

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment

E D.	Voltage	e limits	Current limits		
Frequency Range	Quasi-peak	Average	Quasi-peak Average		
(0.15 – 0.5) MHz	(97 – 87) dBuV	(84 – 74) dBuV	(53 - 43) dBuV	(40 – 30) dBuV	
(0.5 – 30) MHz	87 dBuV	74 dBuV	43 dBuV	30 dBuV	

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150 Ω to the telecommunication port under test (conversion factor is 20 log₁₀ 150/I= 44 dB)

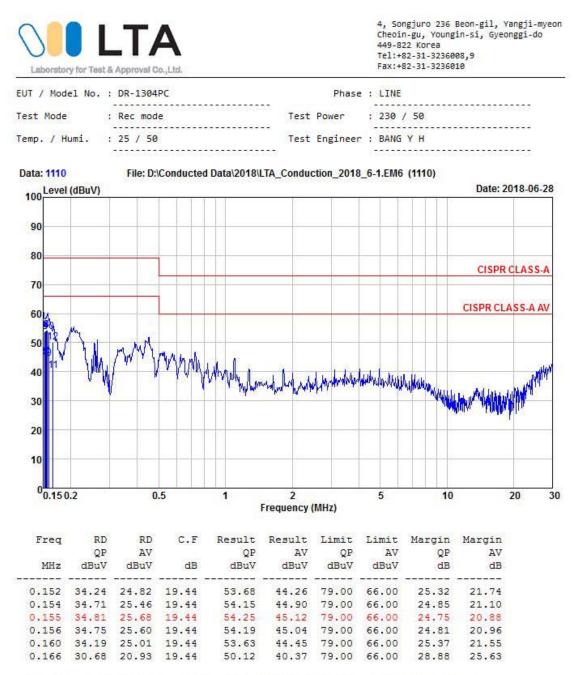
Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment

E	Voltage	e limits	Current limits		
Frequency Range	Quasi-peak Average		Quasi-peak Average		
(0.15 – 0.5) MHz	(84 – 74) dBuV	(74 – 64) dBuV	(40 - 30) dBuV	(30 – 20) dBuV	
(0.5 – 30) MHz	74 dBuV	64 dBuV	30 dBuV	20 dBuV	

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

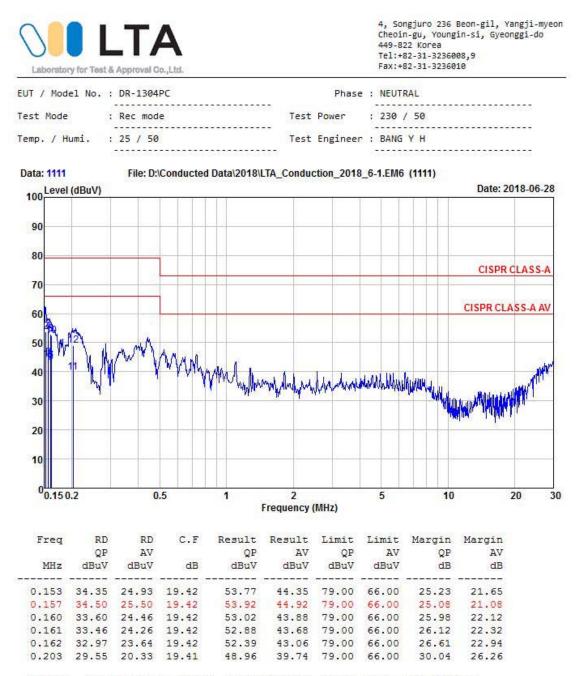
Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I= 44 dB$)

Conducted emissions (LINE)



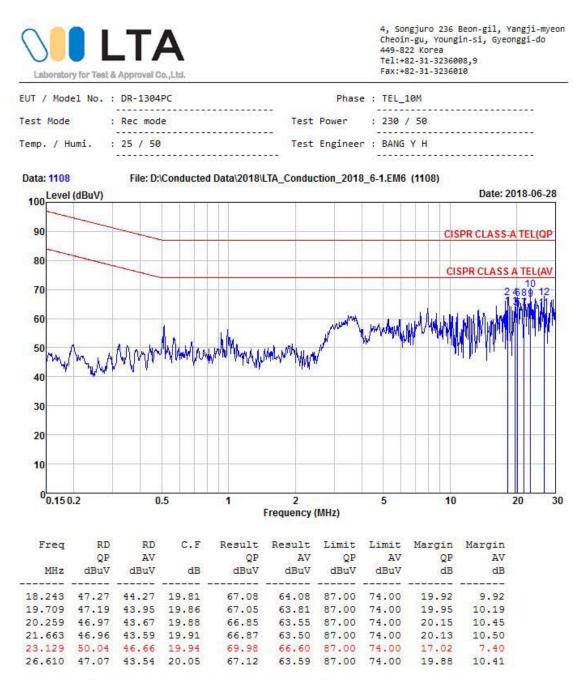
Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (NEUTRAL)



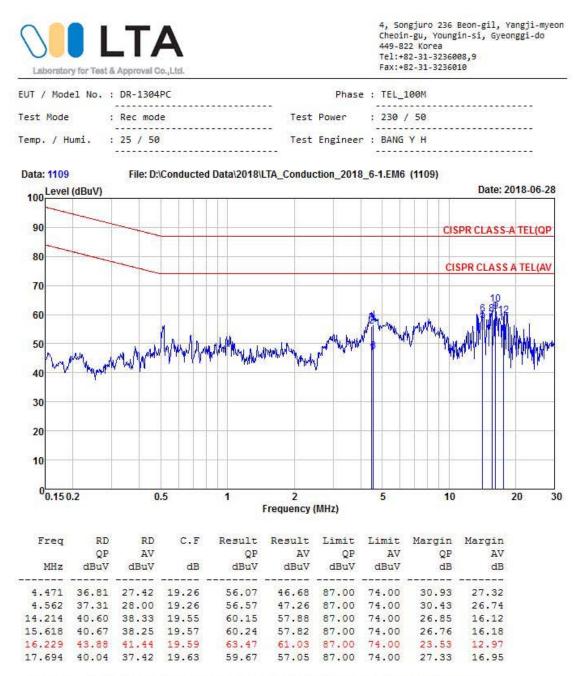
Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_10 M)



Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_100 M)



Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

3.2.2 Radiated Emission

Definition:

The test assesses the ability of ancillary equipment to limit their internal noise from being radiated from the enclosure. We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 55032:2015
Measuring Distance	:	10 m for below 1 GHz $/$ 3 m for above 1 GHz
Measurement Frequency range	:	30 MHz – 6 000 MHz
Measurement RBW	:	120 kHz @ 10 m / 1 MHz @ 3 m
Test mode	:	Rec mode
Result	:	Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)

- The highest internal source of an EUT is higher than 108 MHz, the measurement shall be made up to 6 GHz. (The highest internal source of an EUT : 6 GHz)

A sample calculation:

COR. F (correction factor)= Antenna factor + Cable loss- Amp.gain- Distance correction Emission Level= meter reading + COR.F Limit of 10 m for below 1 GHz

CLASS A

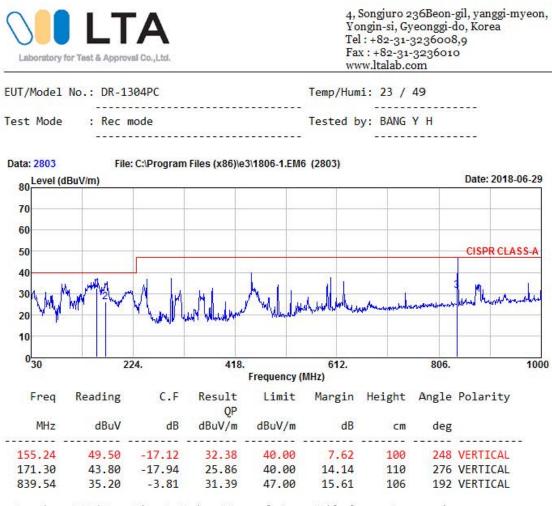
Frequency Range	Quasi-peak
(30 – 230) MHz	40 dBuV/m
(230 – 1 000) MHz	47 dBuV/m
CLASS B	
Frequency Range	Quasi-peak
(30 – 230) MHz	30 dBuV/m
(230 – 1 000) MHz	37 dBuV/m

Limit of 3m for above 1 GHz

CLASS A

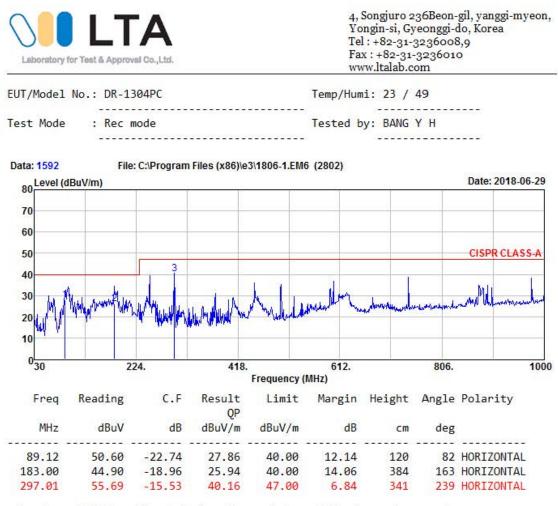
En anna Dan an	Average Limit @ 3m	Peak limit @ 3m	
Frequency Range	(dBµV/m)	$(dB\mu V/m)$	
(1 000 – 3 000) MHz	56	76	
(3 000 – 6 000) MHz	60	80	
NOTE:	The lower limit applies a	t the transition frequency.	
CLASS B			
Erecuency Dones	Average Limit @ 3m	Peak limit @ 3m	
Frequency Range	(dBµV/m)	(dBµV/m)	
(1 000 – 3 000) MHz	50	70	
(3 000 – 6 000) MHz	54	74	
NOTE:	The lower limit applies at the transition frequency.		

Radiated Emission (Below 1 GHz) / V



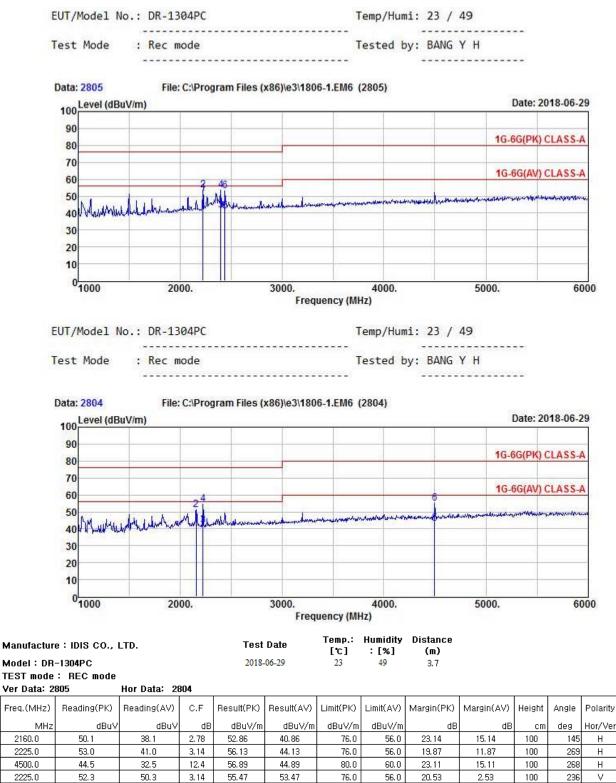
Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / H



Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

- 1 -



Radiated Emission (Above 1 GHz)

2400.0

2440.0

51.5

50.4

39.5

38.4

4.11

4.32

55,63

54.73

43.63

42.73

76.0

76.0

56.0

56.0

20.37

21.27

12.37

13.27

100

100

236

163

٧

V

3.2.3 Harmonic Current (AC power input port)

Definition:

This part deals with the Limitation of harmonic currents injected into the public supply system. We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-3-2:2014
Test mode	:	Rec mode
Rated power	:	10.815 W
Result	:	Not Applicable

Measurement Data:

- We did not test EN61000-3-2 (Harmonic current emissions) for the DR-1304PC because equipment whose rated power is less or equal 75W don't need to be tested.

Harmonic Current (AC power input port)

03rd July 2018 - 20:28:46	Page 1/1	IECSoft v2_5
	BSEN61000-3-2:20	14
M		
N4L	Fluctuating Harmon	nics (assessed to
	Instrument Details	
Instrument Model		5511
Serial Number		04957
Firmware Version		168
N4L Calibration Date		ember 2017
Instrument Version		ndard
Class	Test Settings	ss A
Mode		ss A
Mode	Equipment Under Test	suled
Brand		0., LTD.
Model		304PC
Serial		/A
Impedance Network ID		/A //A
	Test Conditions	/^
	User Entered	Measured
Rated Voltage	N/A	230.906V
Rated Current	N/A	138.874mA
Rated Frequency	N/A	50.000Hz
Rated Power	N/A	10.815W
Idded I ower	Additional Test Informatio	
Measured Power Factor		337
Max Current THD		.83%
Max THC	132.1	51mA
Max Power		946W
Max F.Current	54.3	65mA
Average F.Current	53.4	67mA
Minimum Current		00A
Test Duration	2.5 m	inutes
	Additional Test Details	
Operator	N	/A
Lab Name	N	/A
Location	N	I/A
Notes		
Signature		
Results	Test - N/A. Rate	ed Power < 75W

Test not applicable

With the exception of lighting equipment section 7 of the BSEN61000-3-2:2014 standard declares that no Harmonic current limits are specified for equipment with a rated power of

3.2.4 Voltage Variation and Flicking (AC power input port)

Definition:

This section is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-3-3:2013
Test mode	:	Rec mode
Result	:	Complies

Measurement Data:

- Refer to the Next page

Voltage Variation and Flicking (AC power input port)

03rd July 2018 - 20:38:58	Page 1/2	IECSoft v2_5a			
	61000-3-3:2013 Ec	.3.0			
	Flickermeter				
N4L		Leone of in Arguet (c.)			
	Instrument Details				
Instrument Model	PPA5				
Serial Number	162-04				
Firmware Version	2.16				
N4L Calibration Date	18th Septer				
Instrument Version	Stanc	lard			
	Test Settings				
Class	Volta				
Mode	Norma				
Minimum Current	10.				
PST	10.00 m				
PLT	1 PS	STS			
	Equipment Under Test				
Brand	IDIS CO., LTD.				
Model	DR-1304PC				
Serial	N/.				
Impedance Network ID	N/.	Ą			
	Test Conditions				
	User Entered	Measured			
Rated Voltage	N/A	230.917V			
Rated Current	N/A	N/A			
Rated Frequency	N/A	50.000Hz			
Rated Power	N/A	N/A			
D max	0.0693% (Li				
T max	0.0000 s (Li				
DC max	0.0033% (Li	mit: 3.3%)			
	Additional Test Details				
Operator	N/.				
Lab Name	N/.				
Location	N/.	4			
Notes					
Signature					
Results	Phase1	: PASS			

03rd July	/ 2018 - 20:38:58		Ph:1 Page 2/2				IECS	oft v2_5a
	IEG	C61000-3-3	2013 Ed.3.	0 Flickern	neter			
		Inst	rument De	tails				
Instrume	ent Model			PPA55	11			
Instrume	ent Serial			162-049	957			
Instrume	ent Firmware			2.168	3			
		Equip	ment Unde	er Test				
Brand				IDIS CO.,	LTD.			
Model				DR-1304	4PC			
Serial	Serial N/A							
		Flick	cer Test Re	sults				
PST no.	Status	DC (%)	Dmax (%)	Tmax (s)	PST	PST Lim	PLT	PLT Lin
1	Phase1: PASS	0.003	0.06928	0	0.082	1.00	N/A	N/A

3.3 IMMUNITY

3.3.1 Electrostatic Discharge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of an electrostatic discharge. We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.06.28.
Test method	:	EN 61000-4-2 :2009
Temperature / Humidity / Pressure	:	24 °C / 49 % R.H. / 100.1 kPa
Discharge Impedance	:	$(330\pm\!10\%)\Omega/(150\pm\!10\%)~pF$
Type of Discharge (air discharge)	:	± 2 kV, ± 4 kV, ± 8 kV
Type of Discharge (contact discharge)	:	$\pm 6 \text{ kV}$
Number of discharges at each point	:	10 of each polarity
Discharge Repetition on Rate	:	1 / sec
Test mode	:	Rec mode
Result	:	Complies

Measurement Data:

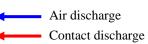
- Refer to the Next page

1-1. Indirect Discharge

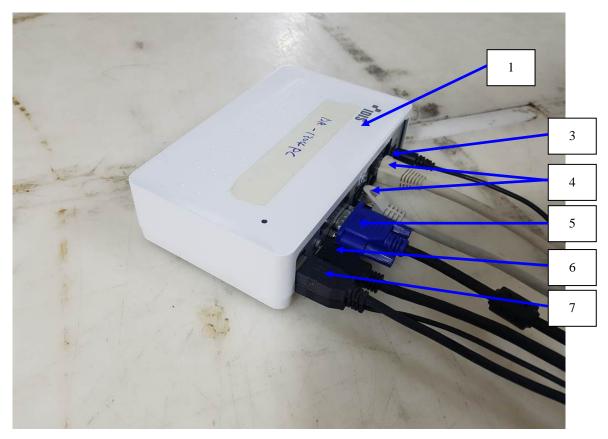
No.	Position	Kind of Discharge		Remarks	
1	НСР	Contact	Complies (A)	No reaction recognized	
2	VCP	Contact	Complies (A)	No reaction recognized	

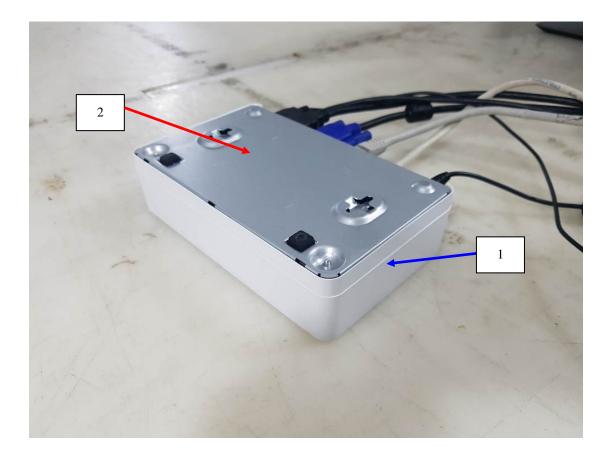
1-2. Direct Discharge

No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure #1	Air	Complies (A)	No reaction recognized
2	Enclosure #2	Contact	Complies (A)	No reaction recognized
3	DC IN	Air	Complies (A)	No reaction recognized
4	LAN	Air	Complies (A)	No reaction recognized
5	VGA	Air	Complies (A)	No reaction recognized
6	HDMI	Air	Complies (A)	No reaction recognized
7	USB	Air	Complies (A)	No reaction recognized



ESD TEST POINT





3.3.2 RF Electromagnetic Field

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic field disturbance.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.07.03.
Test method	:	EN 61000-4-3:2006/A1:2008/A2:2010
Temperature / Humidity / Pressure	:	24 °C / 50 % R.H. / 100.1 kPa
Frequency range	:	80 MHz to 2,700 MHz
Test level	:	10 V/m (measured unmodulated)
Amplitude Modulation	:	AM, 80 %, 1 ^{kHz} Sinusoidal
		PM, 1 Hz (0.5s ON : 0.5s OFF)
Step size	:	1 % of fundamental
Dwell Time	:	3 s
Test mode	:	Rec mode
Result	:	Complies

Port	Side	Result	Remarks
	Front	Complies (A)	No reaction recognized
TT - 1	Left	Complies (A)	No reaction recognized
Horizontal	Rear	Complies (A)	No reaction recognized
	Right	Complies (A)	No reaction recognized
	Front	Complies (A)	No reaction recognized
XI	Left	Complies (A)	No reaction recognized
Vertical	Rear	Complies (A)	No reaction recognized
	Right	Complies (A)	No reaction recognized

3.3.3 Electrical fast transients

Definition:

The test assesses the ability of the EUT to operate as intended in the event of fast transients presence on one of the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.06.29.
Test method	:	EN 61000-4-4:2012
Temperature / Humidity / Pressure	:	23 °C / 50 % R.H. / 100.1 kPa
Cable length	:	> 3 m
Test level	:	2.0 kV (AC power input port)
		1.0 kV (Signal port)
Polarity	:	Negative/ positive
Repetition frequency	:	100 kHz
Test mode		Rec mode
Result	:	Complies

AC power Line	Test level	Result	Remarks
L - N	$\pm 2 \text{ kV}$	Complies (A)	No reaction recognized

Signal Line	Test level	Result	Remarks
LAN	$\pm 1 \mathrm{kV}$	Complies (A)	No reaction recognized

3.3.4 Surge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of surge presence on the AC main power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.06.28.
Test method	:	EN 61000-4-5:2014
Temperature / Humidity / Pressure	:	24 °C / 49 % R.H. / 100.1 kPa
Test level	:	± 0.5 kV, ± 1 kV (line to line)
		\pm 0.5 kV, \pm 1 kV, \pm 2 kV (line to ground),
		± 0.5 kV, ± 1 kV (signal line)
Polarity	:	Negative/ positive
Wave shape	:	1.2/ 50 µs pulse
Number of surges	:	5 (at each phase)
Test mode		Rec mode
Result	:	Complies

Phase	Line	level	Result	Remark
0°	Line(L) to line(N)	\pm 0.5, 1.0 kV	Complies (A)	No reaction recognized
90°	Line(L) to line(N)	\pm 0.5, 1.0 kV	Complies (A)	No reaction recognized
180°	Line(L) to line(N)	\pm 0.5, 1.0 kV	Complies (A)	No reaction recognized
270°	Line(N) to ground(PE)	\pm 0.5, 1.0 kV	Complies (A)	No reaction recognized

3.3.5 Conducted disturbances, induced by radio-frequency fields

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic disturbance on the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.07.02.
Test method	:	EN 61000-4-6:2014/AC:2015
Temperature / Humidity / Pressure	:	24 $^\circ\!\!\mathbb{C}$ / 50 % R.H. / 100.1 kPa
Frequency range	:	$0.15^{\text{MHz}} - 100$ MHz
Test level	:	10 Vrms unmodulated
Amplitude Modulation	:	AM, 80 %, 1 ^{kHz} Sinusoidal
		PM, 1 Hz (0.5s ON : 0.5s OFF)
Step size	:	1 % of fundamental.
Test mode	:	Rec mode
Result	:	Complies

Port	Test level (Vrms)	Result	Remarks
Power Line	10	Complies (A)	No reaction recognized

Port	Test level (Vrms)	Result	Remarks
LAN	10	Complies (A)	No reaction recognized

3.3.6 Mains supply voltage dips, short interruptions

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage dips and interruptions present on

the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.06.29.
Test method	:	EN 61000-4-11:2004/A1:2017
Temperature / Humidity / Pressure	:	23 °C / 50 % R.H. / 100.1 kPa
Ut	:	230 Vac
Test mode	:	Rec mode
Result	:	Complies

Test Level %Ut	Voltage droop and interruptions %Ut	Duration of Reduction (period)	Result	Remarks
80	20	250	Complies (A)	No reaction recognized
70	30	25	Complies (A)	No reaction recognized
40	60	10	Complies (A)	No reaction recognized
0	100	250	Complies (C)	EUT OFF during the test. After the test, EUT was operated normally about user's control.

3.3.7 Mains supply voltage variations

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage variations present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2018.06.29.
Test method	:	EN 50130-4:2011/A1:2014
Temperature / Humidity / Pressure	:	23 °C / 50 % R.H. / 100.1 kPa
Supply Voltage maximum	:	<i>U</i> nom + 10 %
Supply Voltage minimum		Unom – 15 %
Ut	:	230 Vac
Test mode	:	Rec mode
Result	:	Complies

Measurement Data:

Unom = Nominal mains voltage. Where provision is made to adapt the equipment to suit a number of nominal supply voltages (e.g. by transformer tap changing), the above conditioning severity shall be applied for each nominal voltage, with the equipment suitably adapted. For equipment which is claimed to be suitable for a range of nominal mains voltages (e.g. 220/240 V) without adaptation, Umax = (Maximum Unom) + 10 %, and Umin = (Minimum Unom) p 15 %. In any case the range of Unom must include the European nominal mains voltage of 230 V.

2 Mains supply voltage variations

230 V, 50 Hz

Test Lev	velCondition	Test Level (V)	Result	Remarks
Unom	+10%	253	Complies (A)	No reaction recognized
Unom	-15%	195.5	Complies (A)	No reaction recognized

APPENDIX A

TEST EQUIPMENT AND ANCILLARIES USED FOR TESTS

To facilitate inclusion on each page of the test equipment used for related tests, each item of test equipment are identified by the Test Laboratory.

Conducted emissions

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	EMI TEST Receiver	ESR	Rohde & Schwarz	101499	2018.07.11	1 year
\square	Pulse Limiter	ESH3-Z2	Rohde & Schwarz	100710	2019.03.19	1 year
	LISN	ESH3-Z6	Rohde & Schwarz	100378	2018.09.07	1 year
	LISN	ESH3-Z6	Rohde & Schwarz	101468	2018.12.21	1 year
\square	LISN	ENV216	Rohde & Schwarz	100408	2018.09.07	1 year
\square	LISN	LT32C/10	AFJ	32031518210	2018.11.24	1 year
\square	TEST PROGRAM	e3_Ver: 5.5.201a	AUDIX	-	-	-
\square	ISN	ISN T800	TESEQ	27109	2019.01.23	1 year
	ISN	ENY81-CA6	Rohde & Schwarz	101565	2019.01.23	1 year
	CURRENT PROBE	EZ-17	Rohde & Schwarz	100508	2019.01.22	1 year

Radiated Emission – Below 1 GHz

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\boxtimes	EMI TEST Receiver	ESU	Rohde & Schwarz	100092	2018.12.21	1 year
\boxtimes	Amplifier (25 dB)	8447D	HP	2944A07684	2018.09.07	1 year
\boxtimes	TRILOG Antenna	VULB9160	SCHWARZBECK	9160-3237	2019.05.16	2 year
\boxtimes	TEST PROGRAM	e3_Ver: 6.2009- 10-12a	AUDIX	-	-	-

Radiated Emission – Above 1 GHz

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	EMI TEST Receiver	ESU	Rohde & Schwarz	100092	2018.12.21	1 year
\bowtie	Amplifier (25 dB)	8449B	HP	3008A00337	2019.03.19	1 year
\bowtie	HORN ANTENNA	3115	ETS	00055005	2019.05.16	2 year
	TEST PROGRAM	e3_Ver: 6.2009- 10-12a	AUDIX	-	-	-

Harmonic Current / Voltage Variation and Flicking

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
	Precision Power Analyzer	PPA551	Newtons4th Ltd	162-04957	2018.09.18	1 year
\boxtimes	Reference Impedance Network	ES4152	NF Corp.	9074424	2018.09.07	1 year

Electrostatic Discharge

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	ESD Simulator	ESS-2000	NOISEKEN	ESS0625187	2019.03.20	1 year

RF Electromagnetic Field

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	Signal Generator	E4432B	Agilent	MY41310632	2019.05.15	1 year
\square	Power Meter	E4419B	Agilent	GB38410133	2019.05.15	1 year
\boxtimes	RF POWER AMPLIFIER	ITA0300KL-300	INFINITECH	0300KL 1507 001	-	-
\boxtimes	RF POWER AMPLIFIER	ITA2000KL-120	INFINITECH	200KL 1507 001	-	-
\boxtimes	RF POWER AMPLIFIER	ITA4500KL-70	INFINITECH	4500KL 1507 001	-	-
\boxtimes	RF POWER AMPLIFIER	ITA0750KL-300	INFINITECH	0750KL 1507 001	-	-
\boxtimes	LogPer.Antenna (80 毗z ~ 3 毗z)	K9128	RAPA	NONE	-	-

Electrical fast transients

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	Compact Generator	NX5	EMTEST	P1640185038	2019.03.19	1 year
\square	AC Power Source	Variac NX1-260- 16	EMTEST	P1648188071	2019.03.19	1 year
\boxtimes	Capacitive Coupling Clamp	CCI	EMTEST	P1703190739	2019.03.19	1 year

Surge

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	Compact Generator	NX5	EMTEST	P1640185038	2019.03.19	1 year
\boxtimes	AC Power Source	Variac NX1-260- 16	EMTEST	P1648188071	2019.03.19	1 year
	CDN	CNV508N1	EMTEST	P1623180335	2019.03.19	1 year

Conducted disturbances, induced by radio-frequency fields

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	Signal generator	SML03	R&S	103026/0013	2019.03.19	1 year
\square	POWER METER	NRVD	R&S	101689	2019.03.19	1 year
\boxtimes	RF Power Amplifier	FLL75A	FRANKONIA	1033	-	-
\boxtimes	EM INJECTION CLAMP	TSIC-23	F.C.C	529	2019.05.16	1 year
	CDN (M1)	TSCDN-M1-16A	F.C.C	07004	2018.09.07	1 year
\square	CDN (M2)	TSCDN-M2-16A	F.C.C	07008	2018.09.07	1 year
\square	CDN (M3)	TSCDN-M3-16A	F.C.C	07017	2018.09.07	1 year

Mains supply voltage dips, short interruptions

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	Compact Generator	NX5	EMTEST	P1640185038	2019.03.19	1 year
	AC Power Source	Variac NX1-260- 16	EMTEST	P1648188071	2019.03.19	1 year

Mains supply voltage variations

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
\square	Compact Generator	NX5	EMTEST	P1640185038	2019.03.19	1 year
\boxtimes	AC Power Source	Variac NX1-260- 16	EMTEST	P1648188071	2019.03.19	1 year

APPENDIX B

PERFORMANCE CRITERIA

Performance criteria

The variety and the diversity of the apparatus within the scope of this document makes it difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test report, based on the following criteria:

Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m, providing.

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and (c) there is no observable deterioration of the picture at 1 V/m.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Conducted RF immunity

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at $U0 = 130 \text{ dB}\mu N$.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at $U0 = 140 \text{ dB}\mu\text{V}$, providing

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable settings, etc.)

(b) at U0 = 130 dBµV, any deterioration of the picture is so minor that the system could still be used, and

(c) there is no observable deterioration of the picture at $U0 = 120 \text{ dB}\mu N$.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Voltage dip/interruption / Voltage variation

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Mains supply voltage variations

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), during the conditioning.

APPENDIX C

PHOTOGRAPHS



Conducted emission (Maximum emission configuration)

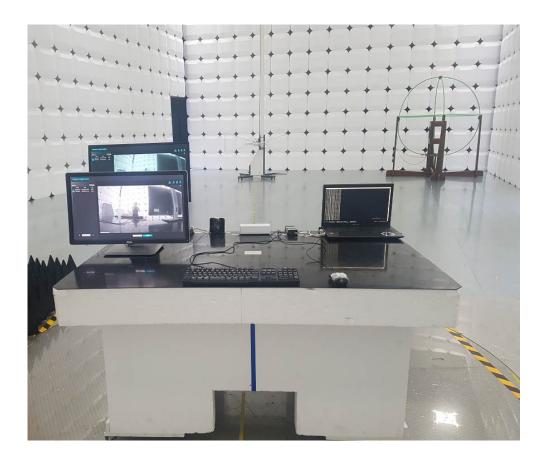




Conducted emission (Maximum emission configuration) _ TEL



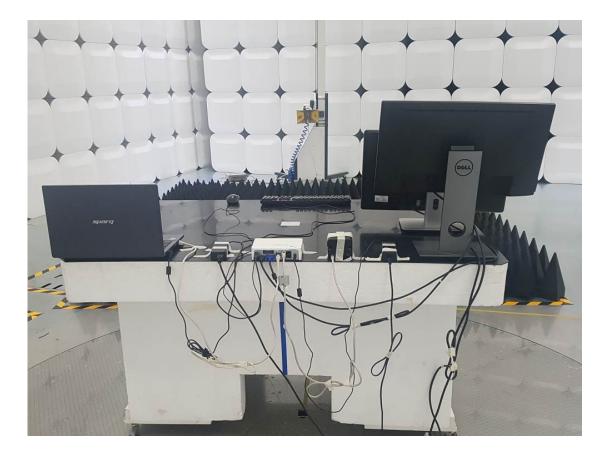
Radiated emission (Maximum emission configuration)-Below 1 GHz







Radiated emission (Maximum emission configuration) – Above 1GHz



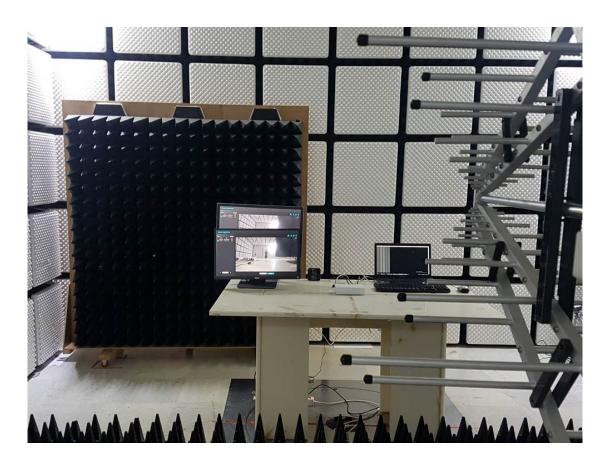


Harmonic Current / Voltage Variation and Flicking

Electrostatic discharge



RF Electromagnetic Field



Copyright © 2018, LTA Co., Ltd.

Electrical fast transients





Surge





Conducted Disturbances, Induced by Radio-Frequency Fields



Main supply voltage dips, short interruptions



